## Notice of References Cited Application/Control No. 10/724,789 Applicant(s)/Patent Under Reexamination FUTOHASHI, ICHIRO Examiner Richard Chan Art Unit Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name		Classification
*	Α	US-6,418,330	07-2002	Lee, Hyeon-Woo	:	455/567
*	В	US-2004/0076278	04-2004	Hayakawa et al.	:	379/207.16
*	C	US-6,058,171	05-2000	Hoopes, Thomas A.	:	379/142.01
*	D	US-6,597,928	07-2003	Ito, Shuhei		455/567
*	E	US-5,452,354	09-1995	Kyronlahti et al.		379/373.02
	F	US-			:	
	O	US-				
	Ι	US-			ŧ	
	_	US-				
	7	US-			:	
	К	US-			:	
	L	US-			:	
	М	US-			:	

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	GB2353442A	02-2001	Great Britain	Tamami Ichihashi	H04M 1/725
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	Q					
	R				<u>:</u>	
	s					
	Т				:	

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.